

## POINTSCAN MEASUREMENT SYSTEM® SPECIFICATIONS SHEET

## **SCANNING INSTRUMENT**



PointScan® unit pictured atop a pressure indicating film image of a fuel cell

The new POINTSCAN Measurement System® is a user-friendly PC-based scanner that enables quick and easy determination of pressure magnitude at any point on the surface of our Fujifilm Prescale® films. The system consists of a Densitometer (scanning instrument), interconnect cables, and conversion software. There is no training required, and very little to learn. Simply enter the requested data (temperature, humidity, time of exposure, and film type) as the system prompts, and pressure magnitude will be displayed in either Metric or English units. The system can read and interpret all five types of Fujifilm Prescale®. Measurements can be outputted to your computer's printer or exported for further analysis in Excel® or Lotus®.

Significant improvements over previous versions include much greater scanning accuracy, Metric and English standards, PC based output to your existing printer, AC operation, multiple aperture dimensions, sturdier scanning instrument, the ability to read Ultra Low (our lowest range) film, and the ability to obtain software upgrades. All parts have a one year warranty, and all software upgrades are free of charge for the first year.

SYSTEM PRICE: \$3,800 Model PDSM

| SYSTEM SPECIFICATIONS         |   |
|-------------------------------|---|
| Spectral Analyzer             | Holographic diffraction grating with 128 pixel diode array  |
| Optical Resolution            | 10nm  |
| Physical Sampling<br>Interval | 3.5nm   |
| Interface                     | USB 1.1   |
| Physical Dimensions           | Length 151mm, width 66mm, height 67mm (6 x 2.6 x 2.6 inches)  |
| Weight                        | 0.4 lb (0.19 kg)  |
| Measurement geometry          | 45°/0° ring illumination optics, DIN 5033   |
| Light source                  | Gas filled tungsten (Type A) No or UV cut (Filters not exchangeable)  |
| Inter-instrument agreement    | Average DE*94 0.4, max. DE*94 1.0 (Deviation from X-Rite manufacturing standard at 23°C for single measurement mode on 12 BCRA tiles (D50.2°) |
| Short-term repeatability      | DE*94 <= 0.1 (D50,2°), with respect to the mean CIELab value of 10 measurements every 3 seconds on white                                      |
| Data format                   | Spectral radiance (mW/nm/m² /sr); Luminance Y (cd/m²)   |
| Measurement range             | 0.2 300 cd/m <sup>2</sup>   |
| Short-term repeatability      | x,y: +/- 0.002 typical (CRT 5000°K, 80 cd/m²)   |
| Туре                          | Cosine-corrected diffuse light measurement head   |
| Diameter                      | 0.24 in (6.0 mm)  |
| Data format                   | Spectral irradiance (mw/nm/m²), Illuminance Y (lux)   |
| Power supply                  | Device powered by USB. USB 1.1 high power device  |
| Compatibility                 | Windows <sup>®</sup>  |



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